

Search Notes	Application No.	Applicant(s)
	09/677,401	KERN ET AL.
	Examiner	Art Unit
	Tan Dean D. Nguyen	3629

SEARCHED			
Class	Subclass	Date	Examiner
705	1	12/10/04	SN
	14		
	17		
	35		
	38		
	39		
463	25		
235	380		
	381	✓	✓

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
I US	12/04	ZRN
PG sub US patent		
II FOREIGN		
1. EPO 2. JPO 3. Derwent		
III NPL		
Reviewing previous case parent	12/04	ZRN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner